

Notice of References Cited

Application/Control No.

10/815,451

Applicant(s)/Patent Under
Reexamination
COATS, ELON RAY

Examiner

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Art Unit

2615

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,864,627	09-1989	Dugan, Daniel W.	381/108
*	B	US-2004/0008851	01-2004	Hagiwara, Hideki	381/104
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

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